

EMC TEST REPORT

REPORT NO. : ADT-EC97056

MODEL NO. : SBC-590

DATE OF TEST: June 29 ~ July 10, 1997

PREPARED FOR: AAEON TECHNOLOGY INC.

ADDRESS: 1F, NO. 6, ALLEY 6, LANE 45, PAO-HSIN RD.,

HSIN-TIEN CITY, TAIPEI, TAIWAN, R.O.C.

PREPARED BY:

ADVANCE DATA TECHNOLOGY CORPORATION

NA(VÒ

12F, NO.1, SEC.4, NAN-KING EAST RD.,

Accredited Laboratry

This test report consists of 29 pages in total. It may be duplicated completely for legal use with the allowance of the applicant. The test result in the report only applies to the tested sample.

TAIPEI, TAIWAN, R.O.C.



TABLE OF CONTENTS

	TIT	LE	PAGE
	CO	VER PAGE	1
1.	CEI	RTIFICATION	3
2.	GE	NERAL INFORMATION	4
	2.1	GENERAL DESCRIPTION OF EUT	4
	2.2	DESCRIPTION OF SUPPORT UNITS	5
	2.3	TEST SETUP	5
3.	TES	T INSTRUMENTS	6
	3.1	TEST INSTRUMENTS (EMISSION)	6
	3.2	TEST INSTRUMENTS (IMMUNITY)	7
4.	TES	T RESULTS (EMISSION)	8
	4.1	RADIO DISTURBANCE	8
		4.1.1 EUT OPERATING CONDITION	8
		4.1.2 TEST DATA OF CONDUCTED EMISSION	9
		4.1.3 TEST DATA OF RADIATED EMISSION	10-11
5.	TES	T RESULTS (IMMUNITY)	12
	5.1	GENERAL DESCRIPTION	12
	5.2	PERFORMANCE CRITERIA DESCRIPTION	12
	5.3	EUT OPERATION CONDITION	12
	5.4	TEST RESULT OF ELECTROSTATIC DISCHARGE (ESD)	13
	5.5	TEST RESULT OF RADIATED RADIO FREQUENCY	14
		ELECTROMAGNETIC FIELDS (RS)	
	5.6	TEST RESULT OF ELECTRICAL FAST TRANSIENT/BURST	15
		(EFT/BURST)	
	5.7	TEST RESULT OF CONDUCTED RADIO FREQUENCY	16
		DISTURBANCES (CS)	
	5.8	TEST RESULT OF POWER FREQUENCY MAGNETIC FIELD	17
	5.9	TEST RESULT OF RADIO-FREQUENCY ELECTROMAGNETIC	18
		FIELD, PULSE MODULATED	
6.	PHO	OTOS OF TEST CONFIGURATION	19-24
7.	CO	NSTRUCTION PHOTOS OF EUT	25-27
8.	ATT	CACHMENT 1 - TECHNICAL DESCRIPTION OF EUT	28-29



CERTIFICATION 1.

Issue date: July 11, 1997

Product

CPU BOARD

Trade Name

AAEON

Model No.

SBC-590

Applicant

AAEON TECHNOLOGY INC.

Standard

EN55 022:1994, Class B EN50 082-2:1995

EN61000-4-2:1995

EN61000-4-3: 1997

EN61000-4-4:1995

EN61000-4-6:1996

EN61000-4-8:1993

ENV50204:1995

We hereby certify that one sample of the designation has been tested in our facility from June 29 to July 10, 1997. The test record, data evaluation and Equipment Under Test (EUT) configurations represent herein are true and accurate representation of the measurements of the sample's EMC characteristics under the conditions herein specified.

PREPARED BY: Slavon Abium, DATE: 7/11/97

APPROVED BY:

, DATE: 7/11/97

(Harris W. Lai)

ADVANCE DATA TECHNOLOGY CORPORATION

Accredited Laboratory



2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF EUT

Product : CPU BOARD

Model No. : SBC-590

Power Supply : DC
Power Cord : N/A

Note: During the test, the EUT was installed in a metal enclosure with a slot board to form an industrial PC. The other parts of industrial PC includes the following:

* Case: AAEON, model: AIPC-110

* Switching power supply: SEASONIC, model: SSG-250G

* VGA Card: CARDEX, model: PCI-S3-765-B2

For more detailed features, please refer to ATTACHMENT 1 - TECHNICAL DESCRIPTION OF EUT and User's Manual.

2.2 GENERAL DESCRIPTION OF APPLIED STANDARD

According to the specifications of manufacturer, the EUT must compliance with the requirements of the following standards:

EN55 022:1994, Class B EN50 082-2:1995

EN61000-4-2:1995 EN61000-4-3:1997 EN61000-4-4:1995 EN61000-4-6:1996

EN61000-4-8:1993

EN61000-4-8:1995

All tests are performed and recorded as per above standards.



2.3 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories are used to form representative test configuration during the tests.

FOR EMISSION TEST

No	Product	Brand	Model No.	Serial No.	I/O Cable
1	COLOR	ACER	7134T	M500233452	Nonshielded Power
	MONITOR				Shielded signal
2	KEYBOARD	ZENITH	KB-5923	TBCM581B780	Shielded signal
3	PRINTER	HP	2225C+	2936S56294	Shielded signal
					Nonshielded Power
4	MODEM X 2	DATATRONICS	1200CK	07-503066	Shielded signal
				02-542194	Nonshielded Power

Note: There is no ferrite core on the interface cable of all support units.

FOR IMMUNITY TEST

No	Product	Manufacturer	Model No.	Serial No.	I/O Cable
1	MONITOR	ACTION	MV-0951	N/A	Shielded Signal
	-				Nonshielded Power
2	KEYBOARD	НР	C3753A	C3753-60223	Shielded Signal
3	PRINTER	HP	C2145A	SG59N16035	Shielded Signal
	****				Nonshielded Power
4	MODEM	HAYES	5300AP	A1425300K045	Shielded signal
				,	Nonshielded Power
5	MODEM	GVC	F-1114V/R6	853E100	Shielded signal
					Nonshielded Power

Note: There is a ferrite core on the interface cable of support unit 1.

There is no ferrite core on the interface cable of other support units.

2.2 Test setup

Please refer to the photos of test configuration in Item 6.



3. TEST INSTRUMENTS

3.1 TEST INSTRUMENTS (EMISSION)

RADIATED EMISSION MEASUREMENT

Description & Manufacturer	Model No.	Serial No.	Date of Calibration
HP Spectrum Analyzer	8594A	3144A00308	Aug. 27, 1996
HP Preamplifier	8447D	2944A08119	Jan. 17, 1997
ROHDE & SCHWARZ	ESVP	893496/030	July 17, 1996
TEST RECEIVER			
SCHWARZBECK Tunable	VHA 9103	E101051	Nov. 30, 1996
Dipole Antenna	UHA 9105	E101055	
CHASE Bilog Antenna	CBL6112	2086	Dec. 28, 1996
EMCO Turn Table	1060	1195	N/A
EMCO Tower	1051	1263	N/A
Open Field Test Site	Site-2	ADT-R02	Oct. 1, 1996

CONDUCTED EMISSION MEASUREMENT

Description & Manufacturer	Model No.	Serial No.	Date of Calibration
ROHDE & SCHWARZ Test	ESH3	893495/006	July 17, 1996
Receiver			
ROHDE & SCHWARZ	EZM	893787/013	July 17, 1996
Spectrum			
ROHDE & SCHWARZ	ESH2-Z5	892107/003	July 25, 1996
Artificial Mains Network			
EMCO-L.I.S.N.	3825/2	9204-1964	July 25, 1996
Shielding Room	Site 2	ADT-C02	N/A

Note: The calibration interval of the above test instruments is 12 months. And the calibrations are traceable to NML/ROC and NIST/USA.



3.2 TEST INSTRUMENTS (IMMUNITY)

Description & Manufacturer	Model No.	Serial No.	Date of Calibration
KeyTek, ESD Test System	2000	9105240/41	Aug. 5, 1996
KeyTek, ESD Simulator	MZ-15/EC	92022232	
KeyTek, EFT Generator	CE-40		June 12,1997
		9508257	Sept. 12, 1996
KeyTek, Capacitive Clamp	CE-40-CCL	9508259	Sept. 12, 1996
KeyTek, Control Center	E103	9508347	N/A
KeyTek, Surge Combination Wave	E501A	9508349	Sept. 20, 1996
KeyTek, Surge Coupler/Decoupler	E551	9508350	Sept. 20, 1996
ROHDE & SCHWARZ	SMY01	840490/009	Oct. 1, 1996
Signal Generator			
KALMUS Power Amplifier	LA1000V	091995-1	N/A
KALMUS Power Amplifier	757LC	091995-2	N/A
HOLADAY Field Probe	HI-4422	89915	Sept. 12, 1996
EMCO BiconiLog Antenna	3141	1001	N/A
FCC Coupling Decoupling	FCC-801-M3-25	48	N/A
Network			
FCC Coupling Decoupling	FCC-801-M2-25	20	N/A
Network			
FCC Coupling Decoupling	FCC-801-M1-25	17	N/A
Network			
BOONTON RF Voltage Meter	9200B	331801AE	Oct. 1, 1996
COMTEST Compact Full	CFAC	ADT-S01	Aug. 2, 1996
Anechoic			U
Chamber (7x3x3 m)			
HAEFELY Mains Interference	PLINE 1610	083690-17	June 20, 1997
Simulator			,
HAEFELY Magnetic Field Tester	MAG 100.1	083794-06	N/A
COMBINOVA Magnetic Field	MFM10	224	June 6, 1997
Meter	2.12.2/110	,	Juliu 0, 1777

Note: The calibration interval of the above test instruments is 12 months. And the calibrations are traceable to NML/ROC and NIST/USA.



4. TEST RESULTS (EMISSION)

4.1 Radio Disturbance

Product Family Standard : EN 55 022, Class B

Frequency Range : 0.15 - 30 MHz (Conducted Emission)

30 - 1000 MHz (Radiated Emission)

Input Voltage : 230 Vac, 50 Hz (to power of Industrial PC)

Temperature : $28 \, ^{\circ}\text{C}$

Humidity : 60%

Atmospheric Pressure : 1060 mbar

TEST RESULT	Remarks
	Minimum passing margin of conducted emission: 11.0 dB at 0.250 MHz
PASS	Minimum passing margin of radiated emission: 3.4 dB at 37.50 MHz

4.1.1 EUT OPERATION CONDITION

- 1. Turn on the power of all equipments.
- 2. Industrial PC reads a test program to enable all functions.
- 3. The Industrial PC reads and writes messages from HDD.
- 4. The Industrial PC sends "H" messages to monitor and monitor display "H" patterns on screen.
- 5. The Industrial PC sends "H" messages to each modem.
- 6. The Industrial PC sends "H" messages to printer, and the printer prints them on paper.
- 7. Repeat steps 2-7.



4.1.2 TEST DATA OF CONDUCTED EMISSION (A)

EUT: CPU BOARD

MODEL: SBC-590

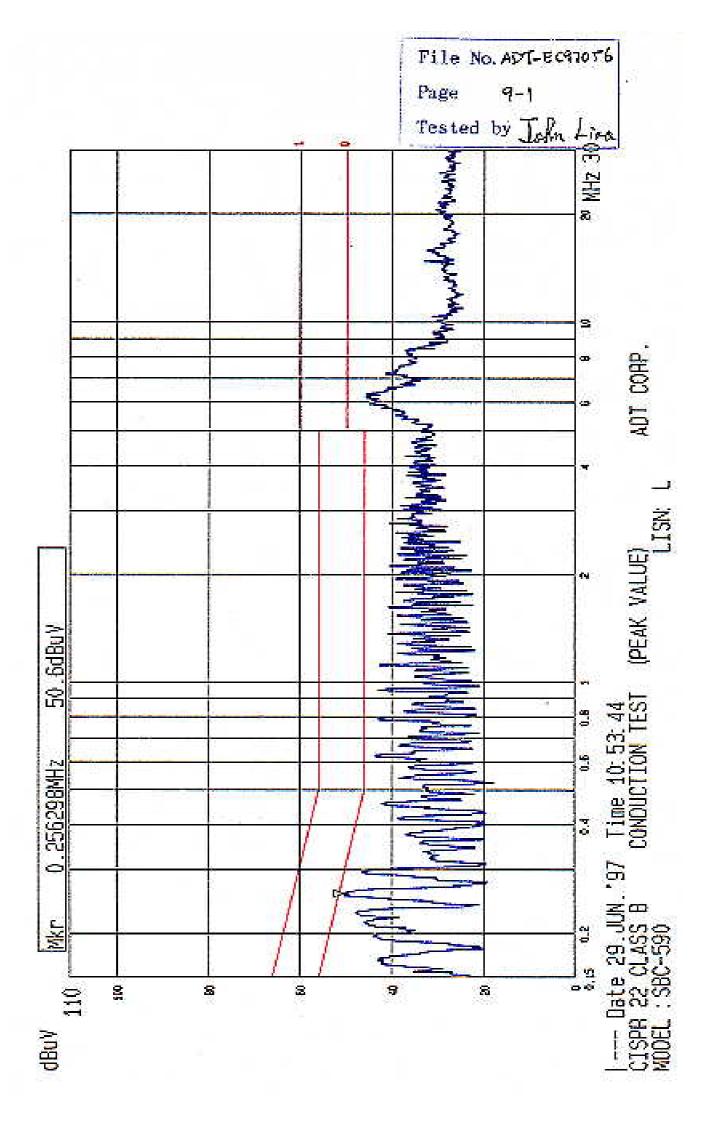
CPU: Pentium 166 MHz

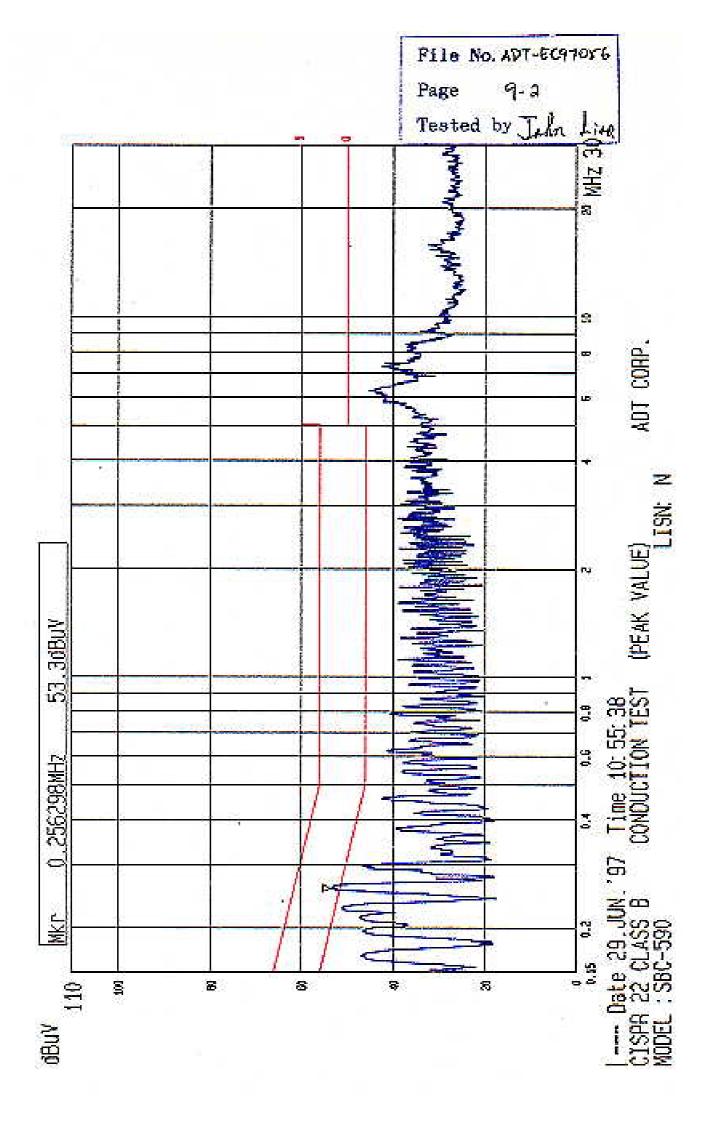
6 dB Band Width: 10 kHz

TEST PERSONNEL: John Liao

Freq.	L1 L	evel	N L	evel	Lir	nit	I	Margin [dB (μV)]
[MHz]	[dB (μ V)]	[dB (μ V)]	[dB (μ V)]	L	. 1	ľ	V
4.4	QP	AV	QP	AV	QP	AV	QP	AV	QP	AV
0.250	49.30	-	50.70	•	61.75	51.75	12.5	_	11.0	-
0.616	41.20	-	38.80	-	56.00	46.00	14.8	-	17.2	_
1.109	38.50	-	38.10	-	56.00	46.00	17.5	-	17.9	-
1.603	37.20	-	36.60	-	56.00	46.00	18.8	-	19.4	-
5.969	38.50	•	37.80	-	60.00	50.00	21.5	-	22.2	-
6.313	39.80	-	39.10	-	60.00	50.00	20.2	-	20.9	-

- Remarks: 1. "*": Undetectable
 - 2. Q.P. and AV. are abbreviations of quasi-peak and average individually.
 - 3. "-": The Quasi-peak reading value also meets average limit and measurement with the average detector is unnecessary.
 - 4. The emission level of other frequencies were very low against the limit.







4.1.3 TEST DATA OF RADIATED EMISSION (A1)

EUT: CPU BOARD

MODEL: SBC-590 CPU: Pentium 166 MHz

ANTENNA: CHASE BILOG CBL6112

POLARITY: Horizontal

DETECTOR FUNCTION: CISPR, Quasi-peak

6 dB BAND WIDTH: 120 kHz

FREQUENCY RANGE: 30-1000 MHz

MEASURED DISTANCE: 10 M

TEST PERSONNEL: John Line

Frequency (MHz)	Correction Factor (dB/m)	Reading Data (dBuV)	Emission Level (dBuV/m)	Limits (dBuV/m)	Margin (dB)
75.06	7.9	11.0	18.9	30.0	-11.1
108.41	13.6	5.1	18.7	30.0	-11.3
125.09	13.4	8.0	21.4	30.0	-8.6
133.43	13.4	5.7	19.1	30.0	-10.9
171.84	11.0	4.5	15.5	30.0	-14.5
190.85	10.9	11.3	22.2	30.0	-7.8
200.13	10.9	10.9	21.8	30.0	-8.2
205.23	11.3	8.6	19.9	30.0	-10.1

REMARKS:

- 1. Emission level (dBuV/m) = Correction Factor(dB/m)+Meter Reading (dBuV).
- 2. Correction Factor(dB/m) = Ant. Factor(dB/m)+Cable loss(dB)
- 3. The other emission levels were very low against the limit.



TEST DATA OF RADIATED EMISSION (A2)

EUT: CPU BOARD MODEL: SBC-590 CPU: Pentium 166 MHz

ANTENNA: CHASE BILOG CBL6112 POLARITY: VERTICAL

DETECTOR FUNCTION: CISPR, Quasi-peak 6 dB BAND WIDTH: 120 kHz

FREQUENCY RANGE: 30-1000 MHz MEASURED DISTANCE: 10 M

TEST PERSONNEL: John Liaa

Frequency	Correction Factor	Reading Data	Emission Level	Limits	Margin
(MHz)	(dB/m)	(dBuV)	(dBuV/m)	(dBuV/m)	(dB)
37.50	14.6	12.0	26.6	30.0	-3.4
51.57	9.0	9.2	18.2	30.0	-11.8
80.94	8.9	14.0	22.9	30.0	-7.1
108.42	12.2	10.0	22.2	30.0	-7.8
125.10	13.3	11.6	24.9	30.0	-5.1
133.42	13.4	9.5	22.9	30.0	-7.1
200.16	12.2	13.3	25.5	30.0	-4.5
205.27	12.3	4.0	16.3	30.0	-13.7
433.65	19.2	1.6	20.8	37.0	-16.2

REMARKS:

^{1.} Emission level (dBuV/m) = Correction Factor(dB/m)

⁺Meter Reading (dBuV). 2. Correction Factor(dB/m) = Ant. Factor(dB/m)+Cable loss(dB)

^{3.} The other emission levels were very low against the limit.



5. TEST RESULTS (IMMUNITY)

5.1 GENERAL DESCRIPTION

Basic Standard : EN61000-4-2 (Electrostatic Discharge Test, ESD)

EN61000-4-3 (Radiated Radio-Frequency

Disturbance Test, RS)

EN61000-4-4 (Electrical Fast Transient/Burst Test, EFT)

EN61000-4-6 (Conducted Radio Frequency

Disturbances Test, CS)

EN61000-4-8 (Power Frequency Magnetic Field Test)

ENV50204 (Radio-Frequency Electromagnetic

Field, Pulse modulated)

Generic Standard

: EN 50 082-2

Input Voltage

230 Vac, 50 Hz (to power of Industrial PC)

Temperature

22 ℃

Humidity

58 %

Atmospheric Pressure:

1060 mbar

5.2 PERFORMANCE CRITERIA DESCRIPTION

Criterion A - The apparatus shall continue to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.

Criterion B - The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended.

Criterion C - Temporary loss of function is allowed, provided the function is self recoverable or can be restored by the operation of the controls.

5.3 EUT OPERATION CONDITION

Industrial PC runs a test program to access FDD/HDD/MODEM/PRINTER sequentially and show the result on monitor screen.



5.4 TEST RESULT OF ELECTROSTATIC DISCHARGE (ESD)

Basic Standard

EN61000-4-2

Generic Standard

EN 50 082-2

Discharge Impedance:

330 ohm / 150.pF

Discharge Voltage

Air Discharge - 8 kV (Direct/Indirect)

(Direct/Indirect)

Contact Discharge - 4 kV

Polarity

Positive/Negative

Number of Discharge:

Minimum 10 times at each test point

Discharge Mode

Single Discharge

Discharge Period

1 second minimum

Test Personnel

- 14 Heuna

Test Result	Remarks
Criterion A PASS	Model: SBC-590

OBSERVATION DESCRIPTION

Direc	t Applica	tion	Test Result		
Discharge Level Polarity (kV) (+/-)		Test Point	Contact Discharge	Air Discharge	
(kV) 4	+	1-4	Note 1	N/A	
8	+	5	N/A	Note 1	

Description of test point:

1. COM ports

2. FDD

3. Power Switch

4. Metal case

5. LPT ports

Indirect Application			Test R	esult
Discharge Level (kV)	Polarity (+/-)	Test Point	Horizontal Coupling	Vertical Coupling
4	+/-	1 ~ 4	Note 1	Note 1

Description of test point:

1. Front side

2. Right side

3. Left side

4. Rear side

Description of test result:

Note 1: There was no change compared with initial operation during the test.



5.5 TEST RESULT OF RADIATED RADIO FREQUENCY DISTURBANCES (RS)

Basic Standard

EN61000-4-3

Generic Standard

EN 50 082-2

Frequency range :

80 MHz - 1000 MHz

Field strength

10 V/m

Modulation

1kHz Sine Wave, 80%, AM Modulation

Frequency step

1 % of fundamental

Polarity of Antenna

Horizontal and Vertical

Test distance

3 m

Test Personnel

Try Yeung

Test Result	Remarks
Criterion A PASS	Model: SBC-590

Note: Four sides of EUT are verified separately.

OBSERVATION DESCRIPTION

There is no change compared with initial operation during the test.



5.6 TEST RESULT OF ELECTRICAL FAST TRANSIENT/BURST (EFT/BURST)

Basic Standard

EN61000-4-4

Generic Standard

EN 50 082-2

Test Voltage

Power Line - 2 kV (to power of Industrial PC)

Signal/Control Line - N/A

Polarity

Positive/Negative

Impulse Frequency:

5 kHz

Tr / Tn

.

Burst Duration

5/50 ns

Duration

15 ms

Burst Period

300 ms

Test Duration

Not less than 1 min.

Test Personnel

To young

Test Result	Remarks
Criterion A PASS	Model: SBC-590

OBSERVATION DESCRIPTION

Test Point	Polarity	Test Level (kV)	Result
L1	+/-	2	Note 1
L2	+/-	2	Note 1
GND	+/-	2	Note 1

Description of test result:

Note1: There is no change compared with initial operation during the test.



5.7 TEST RESULT OF CONDUCTED RADIO FREQUENCY DISTURBANCES (CS)

Basic Standard : EN61000-4-6 Generic Standard : EN 50 082-2

Frequency range : 0.15 MHz - 80 MHz

Field strength : 10 V/m

Modulation : 1kHz Sine Wave, 80%, AM Modulation

Frequency step : 1 % of fundamental

Coupled cable : Power Mains, Unshielded

Coupling device : CDN-M3 (3 wires)

Test Personnel: Ty young

Test Result	Remarks	
Criterion A PASS	Model: SBC-590	

OBSERVATION DESCRIPTION

There is no change compared with initial operation during the test.



5.8 TEST RESULT OF POWER FREQUENCY MAGNETIC FIELD

Basic Standard EN61000-4-8

Generic Standard EN 50 082-2

Frequency range 50Hz Field strength 30 A/m Observation Time 1 minute

Inductance coil Rectangular type, 1mx1m

Test Personnel

Test Result	Remarks	
Criterion A PASS	Model: SBC-590	

OBSERVATION DESCRIPTION

There was no change compared with initial operation during the test.



5.9 TEST RESULT OF RADIO-FREQUENCY ELECTROMAGNETIC FIELD, PULSE MODULATED

Basic Standard

ENV50204

Generic Standard

EN 50 082-2

Frequency range

900 +/- 5 MHz

Field strength

10 V/m

Modulation

200Hz, Square Wave, 50% Duty Cycle

Dewell Time

30 second

Polarity of Antenna :

Horizontal and Vertical

Test distance

3 m

Test Personnel

-Tm General

Test Result	Remarks
Criterion A PASS	Model: SBC-590

Note: Four sides of EUT are verified separately.

OBSERVATION DESCRIPTION

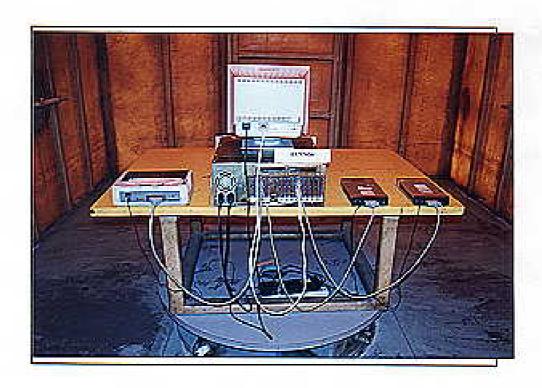
There is no change compared with initial operation during the test.



6. PHOTOGRAPHS OF THE TEST CONFIGURATION







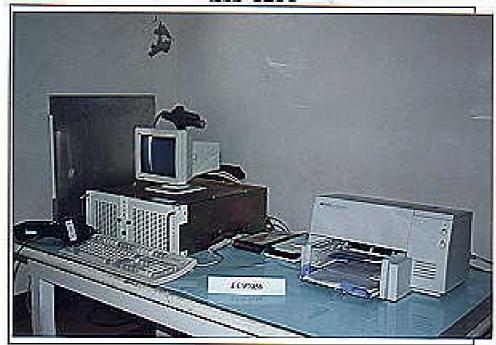


CONDUCTED EMISSION TEST





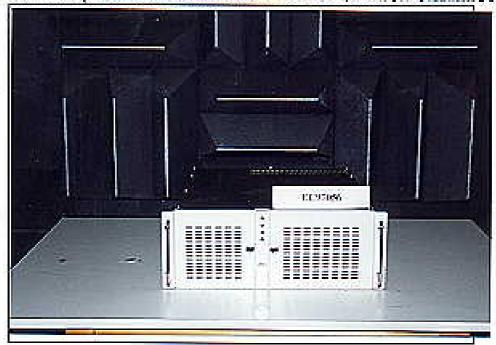
ESD TEST







RS TEST (AM MODULATION AND PULSE MODULATION)







EFT TEST

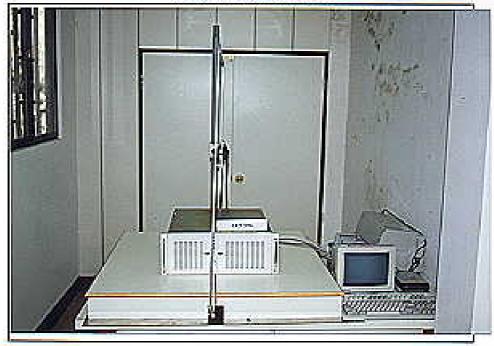




CONDUCTED SUSCEPTIBILITY TEST



MAGNETIC TEST



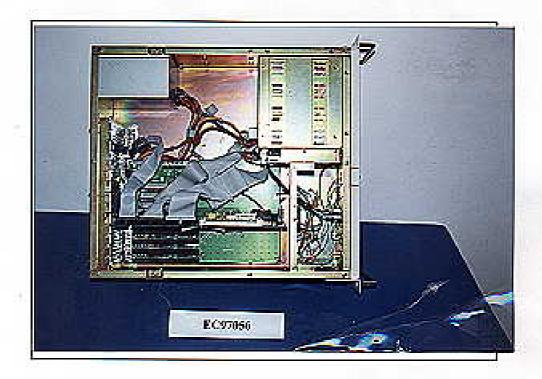


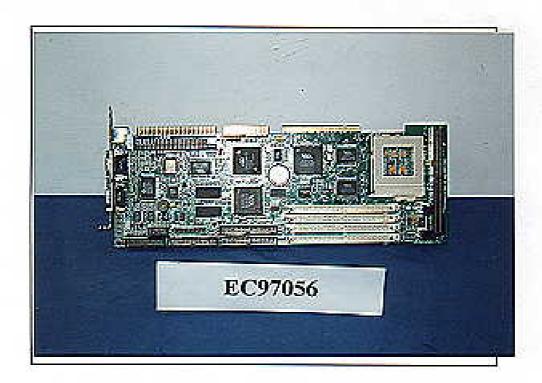
CONSTRUCTION PHOTOS OF EUT 7.

















8. ATTACHMENT I - TECHNICAL DESCRIPTION OF EUT

SPECIFICATIONS:

* CP11

Pentium 166 MHz

* Bus interface.

ISA and PCI (PC/AT) bus

* Data bus

64 bit

* Processing ability

64 bit.

* Chipset

VT 82C575/82C576/82C577

* RAM memory

1 MB to 128 MB. Uses four 72-pin SIMM sockets

supporting EDO RAM

L2 Cache memory size.

256KB/512KB 2rd level cache memory

(Support pipeline burst SRAM module)

Shadow RAM memory

Supports system and video BIOS shadow memory

Feature connector

26-pin header for external VGA display

* Enlanced IDE hard disk

Faust PCI bus, supports up to four enhanced IDE (ATA-2)

* Driver interface

Large hard disk drives or other enhanced IDE devices.

Supports mode 3 and mode 4 hard disks.

Floppy disk drive interface Supports up to two flioppy disk drives, 5.25" and/or 3.5".

* Bidirectional parallel port Configurable to LPT1, LPT2, LPT3 or disabled. Supports

SPP/EPP/ECP standards

Serial ports

Two senal RS-232 ports; use 16C550 UARTs with 16-byte FIFO buffer. Supports speeds up to 115 Kbps. Ports can be individually configured from COM1 to COM4

or disabled

* BIOS

Award BIOS

* Watchdog times

Can generate a system reset or iRQ15. The time interval

is software slectable from 1 to 64 seconds

* PC7104

104-pin connector for a 16-bit bus

* DMA channels

* Interrupt levels

3.5

Keyboard or PS/2 mouse.

A 6-pin mini DIN keyboard connector is located on the

mounting bracket for easy access to the keyboard and

PS/2 mouse

* Bus speed

8 MHz for ISA bus



* Max. power requirements +5Y@5A

* Power supply voltage +5V (4.75V to 5.25V)

* Operating temperature O to 60 °C

* Board size 13.3"(L) x 4.8"(W)

* Board weight 0.5 kg.